

Replace discontinued Toshiba 2SK389 with LSK389

The 2SK389 / LSK389 is a $1\text{nV}/\sqrt{\text{Hz}}$ single chip dual JFET

Why use monolithic dual JFET instead of 2 single JFETS?

2SK389 / LSK389 removes significant cost for test screening time needed to match I_{DSS} on 2 individual JFETS and offers ZERO yield loss.

2SK389 / LSK389 On-Chip I_{DSS} matching gives closest possible synchronous electrical performance and also offers better matched performance when the chip is subjected to temperature.

The 8 Pin SOIC-A provides ease of manufacturing, and the symmetrical pinout prevents improper orientation.

(See Packaging Information).

2SK389 / LSK389 Applications:

- Audio – Amps, effects boxes, microphones
- Instrumentation– Input stages
- Acoustic Sensors – Sonobouys
- Military – Antisubmarine, personnel vehicle detectors, sonar, radiation detectors

FEATURES

ULTRA LOW NOISE	$e_n = 0.9\text{nV} / \sqrt{\text{Hz}}$ (typ)
TIGHT MATCHING	$ V_{GS1-2} = 20\text{mV}$ max
HIGH BREAKDOWN VOLTAGE	$BV_{GSS} = 40\text{V}$ max
HIGH GAIN	$Y_{fs} = 20\text{mS}$ (typ)
LOW CAPACITANCE	25pF (typ)

IMPROVED SECOND SOURCE REPLACEMENT FOR 2SK389

ABSOLUTE MAXIMUM RATINGS¹ @ 25°C (unless otherwise noted)

Maximum Temperatures

Storage Temperature	-65°C to +150°C
Operating Junction Temperature	-55°C to +135°C

Maximum Power Dissipation

Continuous Power Dissipation @ +125°C	400mW
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Maximum Currents

Gate Forward Current	$I_{G(F)} = 10\text{mA}$
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Maximum Voltages

Gate to Source	$V_{GSS} = 40\text{V}$
Gate to Drain	$V_{GDS} = 40\text{V}$

FOR EQUIVALENT SINGLE VERSION, SEE LSK170A

www.micross.com/pdf/LSM_LSK170A_SOT-23.pdf

MATCHING CHARACTERISTICS @ 25°C (unless otherwise stated)

SYMBOL	CHARACTERISTIC	MIN	TYP	MAX	UNITS	CONDITIONS
$ V_{GS1} - V_{GS2} $	Differential Gate to Source Cutoff Voltage	--	--	20	mV	$V_{DS} = 10\text{V}$, $I_D = 1\text{mA}$
I_{DSS1} / I_{DSS2}	Gate to Source Saturation Current Ratio	0.9	--	--	--	$V_{DS} = 10\text{V}$, $V_{GS} = 0\text{V}$

ELECTRICAL CHARACTERISTICS @ 25°C (unless otherwise noted)

SYMBOL	CHARACTERISTICS	MIN.	TYP.	MAX.	UNITS	CONDITIONS	
BV_{GSS}	Gate to Source Breakdown Voltage	40	--	--	V	$V_{DS} = 0$, $I_D = 100\mu\text{A}$	
$V_{GS(OFF)}$	Gate to Source Pinch-off Voltage	0.15	--	2	V	$V_{DS} = 10\text{V}$, $I_D = 0.1\text{mA}$	
I_{DSS}	Drain to Source Saturation Current	2SK389A / LSK389A	2.6	--	6.5	mA	$V_{DS} = 10\text{V}$, $V_{GS} = 0\text{V}$
		2SK389B / LSK389B	6	--	12		
		2SK389C / LSK389C	10	--	20		
I_{GSS}	Gate to Source Leakage Current	--	--	200	pA	$V_{GS} = -30\text{V}$, $V_{DS} = 0\text{V}$	
Y_{fs}	Full Conduction Transconductance	8	20	--	mS	$V_{DS} = 10\text{V}$, $V_{GS} = 0\text{V}$, $I_{DSS} = 3\text{mA}$, $f = 1\text{kHz}$	
e_n	Noise Voltage	--	0.9	1.9	nV/√Hz	$V_{DS} = 10\text{V}$, $I_D = 2\text{mA}$, $f = 1\text{kHz}$, NBW = 1Hz	
e_n	Noise Voltage	--	2.5	4	nV/√Hz	$V_{DS} = 10\text{V}$, $I_D = 2\text{mA}$, $f = 10\text{Hz}$, NBW = 1Hz	
C_{ISS}	Common Source Input Capacitance	--	25	--	pF	$V_{DS} = 10\text{V}$, $V_{GS} = 0\text{V}$, $f = 1\text{MHz}$	
C_{RSS}	Common Source Reverse Transfer Capacitance	--	5.5	--	pF	$V_{DG} = 10\text{V}$, $I_D = 0\text{V}$, $f = 1\text{MHz}$	

Notes:

1. Absolute Maximum ratings are limiting values above which serviceability may be impaired



Available Packages:

LSK389 in SOIC-A
LSK389 available as bare die

Please contact Micross for full package and die dimensions:

Email: chipcomponents@micross.com

Web: www.micross.com/distribution.aspx

SOIC-A (Top View)

